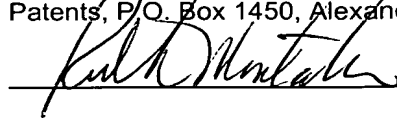


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/ **Ruth Montalvo** Date: **04/28/05**

Customer No. **026418**

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Attorney's Docket No.: **GK-ZEI-3275 / 500343.20295**

U.S. Application No.:

International Application No.: **PCT/EP2003/011927**

International Filing Date: **OCTOBER 28, 2003**

**28 OCTOBER 2003**

Priority Date Claimed: **OCTOBER 28, 2002**

**28 OCTOBER 2002**

Title of Invention: **METHOD FOR IMPROVING DEPTH DISCRIMINATION IN OPTICAL REPRODUCTION SYSTEMS**

Applicant(s) for (DO/EO/US): **Bernhard BACKS, Joerg SCHAFFER, Lutz SCHAEFER and Martin VOELCKER**

Mail Stop PCT  
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P.O. Box 1450  
Alexandria, VA 22313-450

## INFORMATION DISCLOSURE STATEMENT

S I R:

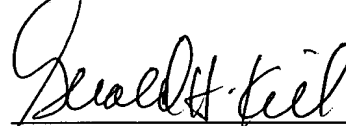
Applicant herewith submits together with the simultaneously filed National Phase application of PCT/EP03/11927, a copy of the International Search Report (PCT/ISA/210) dated February 27, 2004 and German Examination Report (102 50 156833) dated April 3, 2003, citing some of the following references:

	Document Number	Date	Name and/or Country	English Translation
<b>AL</b>	<b>97/06509</b>	<b>02/20/1997</b>	<b>WIPO</b>	
<b>AM</b>	<b>97/45745</b>	<b>10/15/1998</b>	<b>WIPO</b>	
<b>AN</b>	<b>199 30 816</b>	<b>01/04/2001</b>	<b>Germany</b>	Abstract only
<b>AO</b>	<b>02/12945</b>	<b>02/14/2002</b>	<b>WIPO</b>	Abstract only
<b>AP</b>	<b>1 235 424</b>	<b>08/28/2001</b>	<b>European</b>	Abstract only
<b>AQ</b>	<b>101 18 463</b>	<b>10/10/2002</b>	<b>Germany</b>	Abstract only
OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)				
<b>AX</b>	<b>XP-000822234 Applied Spectroscopy, Vol. 53, No. 1, 1999 , 10 pages "Spectral Imaging in a Programmable Array Microscope by Hadamard Transform Fluorescence Spectroscopy" Quentin S. Hanley, et al.</b>			

Accompanying this Information Disclosure Statement and form PTO-1449 are copies of the documents including English Abstracts. Documents AL-AM and A0 are mentioned on pages 2, 4, 7-8, 10 and 19 of the substitute specification.

This submission is not an admission that the information disclosed in the documents is material to the patentability of the invention disclosed and/or claimed in the above-identified application.

Respectfully submitted,



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04/28/05  
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Enclosures:

Search Reports (PCT/ISA/210);  
German Examination Report  
PTO-1449;  
6 Foreign documents  
4 English Abstracts  
Article

**LIST OF PRIOR ART CITED BY APPLICANT**  
(Filed on April 28, 2005)

PTO-1449 Equivalent

Docket No. **GK-ZEI-3275/500343.20295**

Applicant(s): **Bernhard BACKS, Joerg SCHAFFER, Lutz SCHAEFER and Martin VOELCKER**

Application No. (Int'l Appln No. PCT/EP2003/011927 06MAY03) Group:

Filed: Examiner:

**U.S. PATENT DOCUMENTS**

Exam. Init		Document Number	Date	Name	Class	Sub-Class	Filing Date Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

**FOREIGN PATENT DOCUMENTS**

		Document Number	Date	Country	CLASS	Sub-Class	Translation	
							YES	NO
	AL	97/06509	02/20/1997	WIPO				
	AM	97/45745	10/15/1998	WIPO				
	AN	199 30 816	01/04/2001	Germany			Abstract only	
	AO	02/12945	02/14/2002	WIPO			Abstract only	
	AP	1 235 424	08/28/2001	European			Abstract only	
	AQ	101 18 463	10/10/2002	Germany			Abstract only	
	AR							
	AS							
	AT							

**OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

	AX	XP-000822234 Applied Spectroscopy, Vol. 53, No. 1, 1999 , 10 pages "Spectral Imaging in a Programmable Array Microscope by Hadamard Transform Fluorescence Spectroscopy" Quentin S. Hanley, et al.
	AY	
	AZ	

Examiner:

Date:

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.